















ISO7142CC

SLLSEF1B - SEPTEMBER 2013-REVISED AUGUST 2015

ISO7142CC 4242-V_{PK} Small-Footprint and Low-Power Quad Channel Digital Isolator

Features

- Maximum Signaling Rate: 50 Mbps (with 5-V
- Robust Design With Integrated Noise Filter
- Low-Power Consumption, Typical I_{CC} per Channel (with 3.3-V Supplies):
 - 1.3 mA at 1 Mbps, 2.5 mA at 25 Mbps
- Wide Temperature Range: -55°C to 125°C
- 50 kV/µs Transient Immunity, Typical
- Long Life with SiO₂ Isolation Barrier
- Operates From 2.7-V, 3.3-V and 5-V Supply
- 2.7-V to 5.5-V Level Translation
- Small QSOP-16 Package
- Safety and Regulatory Approvals
 - 2500-V_{RMS} Isolation for 1 Minute per UL 1577
 - 4242-V_{PK} Isolation per DIN V VDE V 0884-10 (VDE V 0884-10):2006-12
 - CSA Component Acceptance Notice 5A, IEC 60950-1 and IEC 61010-1 End Equipment Standards
 - CQC Certification per GB4943.1-2011

2 Applications

- General Purpose Isolation
- Industrial Automation
- Motor Control
- Solar Inverters

3 Description

ISO7142CC provides galvanic isolation up to 2500-V_{RMS} for 1 minute per UL and 4242-V_{PK} per VDE. ISO7142CC is a quad-channel isolator with two forward and two reverse-direction channels. This device is capable of maximum data rate of 50 Mbps with 5-V supplies and 40 Mbps with 3.3-V or 2.7-V supplies. ISO7142CC has integrated filters on the inputs to support noise-prone applications.

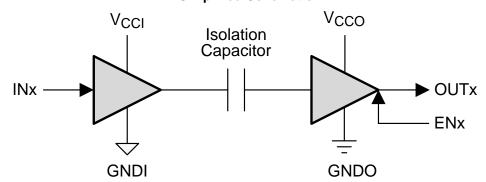
Each isolation channel has a logic input and output buffer separated by a silicon dioxide (SiO₂) insulation barrier. Used in conjunction with isolated power supplies, this device prevents noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry. This device has TTL input thresholds and can operate from 2.7-V, 3.3-V, and 5-V supplies.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
ISO7142CC	SSOP (16)	4.90 mm × 3.90 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Simplified Schematic



- (1) V_{CCI} and GNDI are supply and ground connections respectively for the input channels.
- (2) V_{CCO} and GNDO are supply and ground connections respectively for the output channels.

Page



Table of Contents

1	Features 1	7	Parameter Measurement Information	10
2	Applications 1	8	Detailed Description	12
3	Description 1		8.1 Overview	
4	Revision History2		8.2 Functional Block Diagram	12
5	Pin Configuration and Functions3		8.3 Feature Description	13
6	Specifications4		8.4 Device Functional Modes	15
U	6.1 Absolute Maximum Ratings	9	Application and Implementation	16
	6.2 ESD Ratings		9.1 Application Information	16
	6.3 Recommended Operating Conditions		9.2 Typical Application	16
	6.4 Thermal Information	10	Power Supply Recommendations	18
	6.5 Electrical Characteristics, 5 V	11	Layout	
	6.6 Electrical Characteristics, 3.3 V		11.1 Layout Guidelines	
	6.7 Electrical Characteristics, 2.7 V		11.2 Layout Example	
	6.8 Power Dissipation Characteristics 5	12	Device and Documentation Support	20
	6.9 Switching Characteristics, 5 V		12.1 Documentation Support	
	6.10 Switching Characteristics, 3.3 V		12.2 Community Resources	
	6.11 Switching Characteristics, 2.7 V		12.3 Trademarks	
	6.12 Supply Current, 5 V		12.4 Electrostatic Discharge Caution	20
	6.13 Supply Current, 3.3 V 7		12.5 Glossary	
	6.14 Supply Current, 2.7 V 7	13	Mechanical, Packaging, and Orderable	
	6.15 Typical Characteristics 8		Information	20
	0.10 Typical Orial actoristics			•••

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

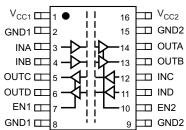
Changes from Revision A (September 2013) to Revision B

•	Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	1
•	Changed VDE Standard to DIN V VDE V 0884-10 (VDE V 0884-10)2006-12	1
C	hanges from Original (September 2013) to Revision A	Page
•	Deleted the MIN value of -55°C from T _J in the RECOMMENDED OPERATING CONDITIONS table	4



5 Pin Configuration and Functions





Pin Functions

PIN NAME NO.		I/O	DESCRIPTION
		1/0	DESCRIPTION
EN1	7	I	Output enable 1. Output pins on side 1 are enabled when EN1 is high or open and in high-impedance state when EN1 is low.
EN2	10	I	Output enable 2. Output pins on side 2 are enabled when EN2 is high or open and in high-impedance state when EN2 is low.
GND1	2,8	_	Ground connection for V _{CC1}
GND2	9,15	_	Ground connection for V _{CC2}
INA	3	I	Input, channel A
INB	4	I	Input, channel B
INC	12	I	Input, channel C
IND	11	I	Input, channel D
OUTA	14	0	Output, channel A
OUTB	13	0	Output, channel B
OUTC	5	0	Output, channel C
OUTD	6	0	Output, channel D
V _{CC1}	1	_	Power supply, V _{CC1}
V _{CC2}	16	_	Power supply, V _{CC2}

Copyright © 2013–2015, Texas Instruments Incorporated



6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾

		MIN	MAX	UNIT
V _{CC1} , V _{CC2}	Supply voltage ⁽²⁾	-0.5	6	V
V	Voltage at INx, OUTx, ENx	-0.5	$V_{CC} + 0.5^{(3)}$	V
Io	Output current	-15	15	mA
TJ	Maximum junction temperature		150	°C
T _{stg}	Storage temperature	-65	150	°C

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GND1 or GND2) and are peak voltage values.
- (3) Maximum voltage must not exceed 6 V.

6.2 ESD Ratings

				VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±4000		
	$V_{(ESD)}$	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1500	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V _{CC1} , V _{CC2}	Supply voltage	2.7		5.5	V
	High-level output current (V _{CC} ≥ 3.0 V)	-4			A
I _{OH}	High-level output current (V _{CC} < 3.0 V)	-2			mA
I _{OL}	Low-level output current			4	mA
V_{IH}	High-level input voltage	2		5.5	V
V _{IL}	Low-level input voltage	0		0.8	V
	Input pulse duration (V _{CC} ≥ 4.5V)	20			20
t _{ui}	Input pulse duration (V _{CC} < 4.5V)	25			ns
4 / +	Signaling rate (V _{CC} ≥ 4.5V)	0		50	Mhna
1 / t _{ui}	Signaling rate (V _{CC} < 4.5V)	0		40	Mbps
T _J	Junction temperature			136	°C
T _A	Ambient temperature	– 55	25	125	°C

6.4 Thermal Information

		ISO7142CC	
	THERMAL METRIC ⁽¹⁾	DBQ (SSOP)	UNIT
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	104.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case(top) thermal resistance	57.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	46.8	°C/W
ΨЈТ	Junction-to-top characterization parameter	18.3	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	46.4	°C/W

 For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

Product Folder Links: ISO7142CC



6.5 Electrical Characteristics, 5 V

 V_{CC1} and V_{CC2} at 5 V \pm 10% (over recommended operating conditions unless otherwise noted.)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V	High lovel output voltage	I _{OH} = -4 mA; see Figure 8	V _{CCO} ⁽¹⁾ – 0.5			V
V _{OH}	High-level output voltage	$I_{OH} = -20 \mu A$; see Figure 8	V _{CCO} - 0.1			V
V	Low-level output voltage	I _{OL} = 4 mA; see Figure 8			0.4	V
V _{OL}		I_{OL} = 20 μ A; see Figure 8			0.1	V
V _{I(HYS)}	Input threshold voltage hysteresis			480		mV
I _{IH}	High-level input current	V _{IH} = V _{CCI} ⁽¹⁾ at INx or ENx			10	
I _{IL}	Low-level input current	V _{IL} = 0 V at INx or ENx	-10			μA
CMTI	Common-mode transient immunity	V _I = V _{CCI} or 0 V; see Figure 11	25	70		kV/µs

⁽¹⁾ V_{CCI} = Supply voltage for the input channel; V_{CCO} = Supply voltage for the output channel

6.6 Electrical Characteristics, 3.3 V

 V_{CC1} and V_{CC2} at 3.3 V \pm 10% (over recommended operating conditions unless otherwise noted.)

001	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	. 0	,			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
\/	High lovel output voltage	I _{OH} = -4 mA; see Figure 8	$V_{\rm CCO}^{~(1)} - 0.5$			٧
V _{OH}	High-level output voltage	$I_{OH} = -20 \mu A$; see Figure 8	V _{CCO} - 0.1			V
	Low-level output voltage	I _{OL} = 4 mA; see Figure 8			0.4	V
V _{OL}		I _{OL} = 20 μA; see Figure 8			0.1	V
V _{I(HYS)}	Input threshold voltage hysteresis			460		mV
I _{IH}	High-level input current	$V_{IH} = V_{CCI}^{(1)}$ at INx or ENx			10	
I _{IL}	Low-level input current	V _{IL} = 0 V at INx or ENx	-10			μA
CMTI	Common-mode transient immunity	V _I = V _{CCI} or 0 V; see Figure 11	25	50		kV/µs

⁽¹⁾ V_{CCI} = Supply voltage for the input channel; V_{CCO} = Supply voltage for the output channel

6.7 Electrical Characteristics, 2.7 V

V_{CC1} and V_{CC2} at 2.7 V (over recommended operating conditions unless otherwise noted.)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Lligh lovel output voltage	I _{OH} = -2 mA; see Figure 8	$V_{CCO}^{(1)} - 0.3$			V
V _{OH}	High-level output voltage	$I_{OH} = -20 \mu A$; see Figure 8	V _{CCO} - 0.1			V
	Low lovel output voltage	I _{OL} = 4 mA; see Figure 8			0.4	V
V _{OL}	Low-level output voltage	$I_{OL} = 20 \mu A$; see Figure 8			0.1	V
V _{I(HYS)}	Input threshold voltage hysteresis			360		mV
I _{IH}	High-level input current	V _{IH} = V _{CCI} ⁽¹⁾ at INx or ENx			10	
I _{IL}	Low-level input current	V _{IL} = 0 V at INx or ENx	-10			μA
CMTI	Common-mode transient immunity	V _I = V _{CCI} or 0 V; see Figure 11	25	45		kV/µs

⁽¹⁾ V_{CCI} = Supply voltage for the input channel; V_{CCO} = Supply voltage for the output channel

6.8 Power Dissipation Characteristics

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
P_D	Device power dissipation	$V_{CC1} = V_{CC2} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C}, C_L = 15 \text{ pF}$ Input a 25-MHz, 50% duty cycle square wave			170	mW

Product Folder Links: ISO7142CC



6.9 Switching Characteristics, 5 V

V_{CC1} and V_{CC2} at 5 V ± 10% (over recommended operating conditions unless otherwise noted.)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 8	15	21	38	ns
PWD ⁽¹⁾	Pulse width distortion t _{PHL} - t _{PLH}	See Figure 8			3.5	ns
t _{sk(o)} (2)	Channel to show a lawtout about in a	Same-direction channels			1.5	
	Channel-to-channel output skew time	Opposite-direction channels			6.5	ns
t _{sk(pp)} (3)	Part-to-part skew time				14	ns
t _r	Output signal rise time	See Figure 8		2.5		ns
t _f	Output signal fall time	See Figure 8		2.1		ns
t _{PHZ} , t _{PLZ}	Disable propagation delay, high/low-to-high impedance output	See Figure 9		7	12	ns
t _{PZH}	Enable propagation delay, high impedance-to-high output	See Figure 9		6	12	ns
t _{PZL}	Enable propagation delay, high impedance-to-low output	See Figure 9		12	23	us
t _{fS}	Fail-safe output delay time from input data or power loss	See Figure 10		8		μs
t _{GR}	Input glitch rejection time			9.5		ns

⁽¹⁾ Also known as pulse skew

6.10 Switching Characteristics, 3.3 V

 V_{CC1} and V_{CC2} at 3.3 V \pm 10% (over recommended operating conditions unless otherwise noted.)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}, t_{PHL}	Propagation delay time	See Figure 8	16	25	46	ns
PWD ⁽¹⁾	Pulse width distortion t _{PHL} - t _{PLH}	See Figure 8			3	ns
t _{sk(o)} (2)	Channel to channel output alcourtime	Same-direction Channels			2	
		Channel-to-channel output skew time	Opposite-direction Channels			6.5
t _{sk(pp)} (3)	Part-to-part skew time				21	ns
t _r	Output signal rise time	See Figure 8		3		ns
t _f	Output signal fall time	See Figure 8		2.5		ns
t_{PHZ} , t_{PLZ}	Disable propagation delay, from high/low to high-impedance output	See Figure 9		9	14	ns
t _{PZH}	Enable propagation delay, from high-impedance to high output	See Figure 9		9	17	ns
t _{PZL}	Enable propagation delay, from high-impedance to low output	See Figure 9		12	24	us
t _{fs}	Fail-safe output delay time from input data or power loss	See Figure 10		7		μs
t _{GR}	Input glitch rejection time			11		ns

⁽¹⁾ Also known as pulse skew

Submit Documentation Feedback

Copyright © 2013–2015, Texas Instruments Incorporated

⁽²⁾ t_{sk(o)} is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

⁽³⁾ t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals, and loads.

⁽²⁾ t_{sk(o)} is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

⁽³⁾ t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.



6.11 Switching Characteristics, 2.7 V

V_{CC1} and V_{CC2} at 2.7 V (over recommended operating conditions unless otherwise noted.)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 8	18	28	50	ns
PWD ⁽¹⁾	Pulse width distortion t _{PHL} - t _{PLH}	See Figure 8			3	ns
t _{sk(0)} (2)	Channel to about all autout all autout	Same-direction Channels			3	ns
	Channel-to-channel output skew time	Opposite-direction Channels			8.5	ns
t _{sk(pp)} (3)	Part-to-part skew time				24	ns
t _r	Output signal rise time	See Figure 8		3.5		ns
t_f	Output signal fall time	See Figure 8		2.8		ns
t _{PHZ} , t _{PLZ}	Disable propagation delay, from high/low to high-impedance output	See Figure 9		10	15	ns
t _{PZH}	Enable propagation delay, from high-impedance to high output	See Figure 9		10	19	ns
t _{PZL}	Enable propagation delay, from high-impedance to low output	See Figure 9		12	23	us
t _{fS}	Fail-safe output delay time from input data or power loss	See Figure 10		7		μs
t _{GR}	Input glitch rejection time			12		ns

⁽¹⁾ Also known as pulse skew

6.12 Supply Current, 5 V

 V_{CC1} and V_{CC2} at 5 V \pm 10% (over recommended operating conditions unless otherwise noted.)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{CC1} , I _{CC2}	Disable	EN1 = EN2 = 0 V		0.8	1.6	
I _{CC1} , I _{CC2}	DC to 1 Mbps			3.3	5	
I _{CC1} , I _{CC2}	10 Mbps	DC Signal: $V_1 = V_{CC1}$ or 0 V, AC Signal: All channels switching with square wave		4.9	7	mA
I _{CC1} , I _{CC2}	25 Mbps	clock input; C ₁ = 15 pF		7.3	10	
I _{CC1} , I _{CC2}	50 Mbps			11.1	14.5	

6.13 Supply Current, 3.3 V

 V_{CC1} and V_{CC2} at 3.3 V \pm 10% (over recommended operating conditions unless otherwise noted.)

Total and Total and Television (ever recommended operating contained annex annex modernes)										
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT				
I _{CC1} , I _{CC2}	Disable	EN1 = EN2 = 0 V		0.5	1					
I _{CC1} , I _{CC2}	DC to 1 Mbps			2.5	4					
I _{CC1} , I _{CC2}	10 Mbps	DC signal: V _I = V _{CCI} or 0 V		3.5	5	mA				
I _{CC1} , I _{CC2}	25 Mbps	AC signal: All channels switching with square-wave clock input; C _I = 15 pF		5	7					
I _{CC1} , I _{CC2}	40 Mbps			6.5	10					

6.14 Supply Current, 2.7 V

V_{CC1} and V_{CC2} at 2.7 V (over recommended operating conditions unless otherwise noted.)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{CC1} , I _{CC2}	Disable	EN1 = EN2 = 0 V		0.4	0.8	
I _{CC1} , I _{CC2}	DC to 1 Mbps			2.2	3.5	
I _{CC1} , I _{CC2}	10 Mbps	DC signal: V _I = V _{CCI} or 0 V		3	4.2	mA
I _{CC1} , I _{CC2}	25 Mbps	AC signal: All channels switching with square-wave clock input; C _I = 15 pF		4.2	5.5	
I _{CC1} , I _{CC2}	40 Mbps	, ,		5.4	7.5	

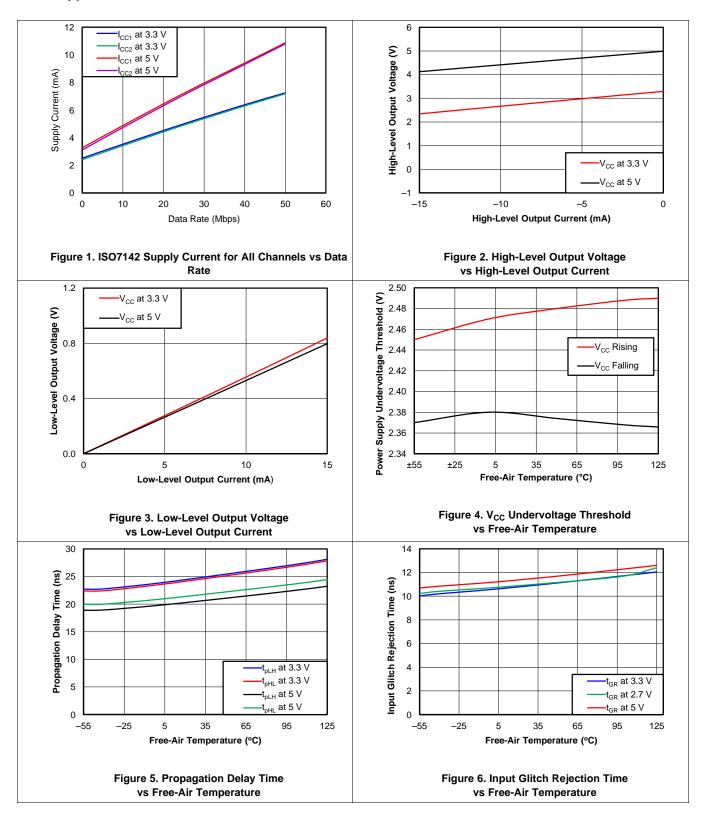
Product Folder Links: ISO7142CC

⁽²⁾ t_{sk(o)} is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

⁽³⁾ t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals, and loads.

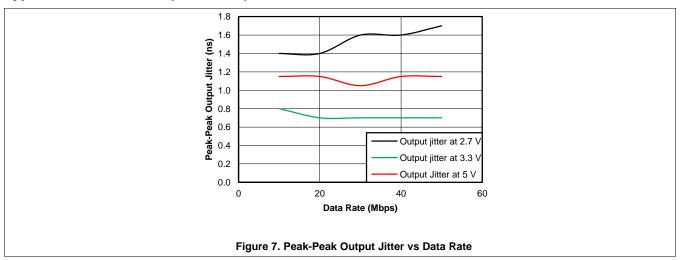


6.15 Typical Characteristics



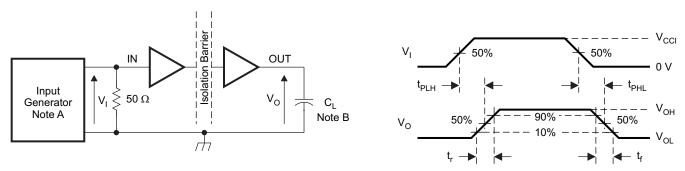


Typical Characteristics (continued)



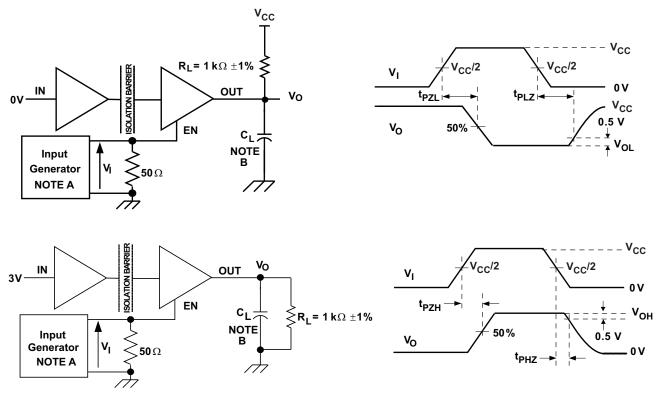
TEXAS INSTRUMENTS

7 Parameter Measurement Information



- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns, $t_G =$ 50 Ω . At the input, a 50- Ω resistor is required to terminate the input-generator signal. It is not needed in an actual application.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 8. Switching-Characteristics Test Circuit and Voltage Waveforms

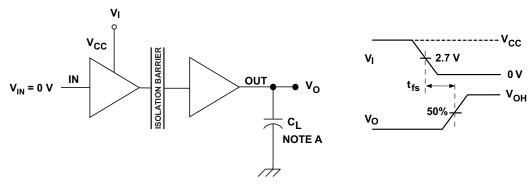


- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns, $Z_O =$ 50 Ω .
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 9. Enable/Disable Propagation Delay-Time Test Circuit and Waveform

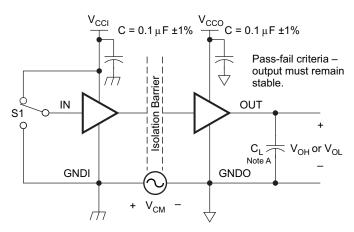


Parameter Measurement Information (continued)



A. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 10. Failsafe Delay-Time Test Circuit and Voltage Waveforms



A. $C_L = 15pF$ and includes instrumentation and fixture capacitance within ±20%.

Figure 11. Common-Mode Transient Immunity Test Circuit

Copyright © 2013–2015, Texas Instruments Incorporated



8 Detailed Description

8.1 Overview

The isolator in Figure 12 is based on a capacitive isolation barrier technique. The I/O channel of the device consists of two internal data channels, a high-frequency channel (HF) with a bandwidth from 100 kbps up to 50 Mbps, and a low-frequency channel (LF) covering the range from 100 kbps down to DC. In principle, a single-ended input signal entering the HF-channel is split into a differential signal through the inverter gate at the input. The following capacitor-resistor networks differentiate the signal into transients, which then are converted into differential pulses by two comparators. The comparator outputs drive a NOR-gate flip-flop whose output feeds an output multiplexer. A decision logic (DCL) at the driving output of the flip-flop measures the durations between signal transients. If the duration between two consecutive transients exceeds a certain time limit, (as in the case of a low-frequency signal), the DCL forces the output-multiplexer to switch from the high- to the low-frequency channel.

Because low-frequency input signals require the internal capacitors to assume prohibitively large values, these signals are pulse-width modulated (PWM) with the carrier frequency of an internal oscillator, thus creating a sufficiently high frequency signal, capable of passing the capacitive barrier. As the input is modulated, a low-pass filter (LPF) is needed to remove the high-frequency carrier from the actual data before passing it on to the output multiplexer.

8.2 Functional Block Diagram

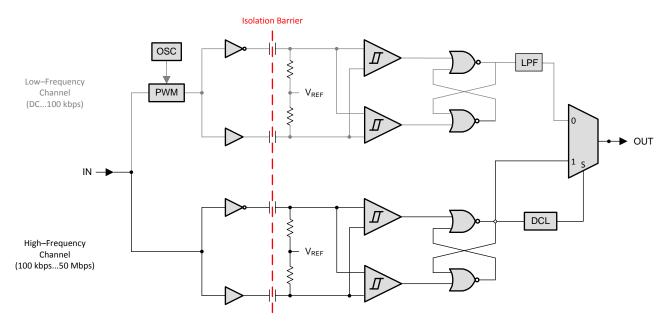


Figure 12. Conceptual Block Diagram of a Digital Capacitive Isolator



8.3 Feature Description

8.3.1 Insulation and Safety-Related Specifications

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DTI	Distance through the insulation	Minimum internal gap (internal clearance)	0.014			mm
C _I (1)	Input capacitance	$V_1 = V_{CC}/2 + 0.4 \sin(2\pi ft), f = 1 \text{ MHz}, V_{CC} = 5 \text{ V}$		2		рF
DIN V V	/DE V 0884-10 (VDE V 0884-10):2006	S-12			•	
V_{IOTM}	Maximum transient isolation voltage				4242	V_{PK}
V_{IORM}	Maximum working isolation voltage				566	V_{PK}
		After Input/Output safety test subgroup 2/3, V _{PR} = V _{IORM} x 1.2, t = 10 s, Partial discharge < 5 pC			679	
V_{PR}	Input-to-output test voltage	Method a, After environmental tests subgroup 1, $V_{PR} = V_{IORM} \times 1.6$, $t = 10 \text{ s}$, Partial discharge < 5 pC			906	V _{PK}
		Method b1, 100% production test, $V_{PR} = V_{IORM} \times 1.875$, $t = 1 \text{ s}$, Partial discharge < 5 pC	$= V_{IORM} \times 1.875, t = 1 s,$		1061	
L(I01)	Minimum air gap (clearance)	Shortest terminal to terminal distance through air	3.7			mm
L(102)	Minimum external tracking (creepage)	Shortest terminal to terminal distance across the package surface	3.7			mm
	Pollution degree			2		
СТІ	Tracking resistance (comparative tracking index)	DIN EN 60112 (VDE 0303-11); IEC 60112	≥400			V
		V _{IO} = 500 V, T _A = 25°C		>10 ¹²		
R_{IO} (2)	Isolation resistance, input to output	$V_{IO} = 500 \text{ V}, 100^{\circ}\text{C} \le T_{A} \le 125^{\circ}\text{C}$		>10 ¹¹		Ω
		V _{IO} = 500 V, T _S = 150°C		>10 ⁹		
C _{IO} (2)	Barrier capacitance, input to output	V _I = 0.4 sin (2πft), f = 1 MHz		2.4		pF
UL 157	7					
V _{ISO}	Withstanding Isolation voltage	$\begin{array}{l} V_{TEST} = V_{ISO} = 2500 \ V_{RMS}, 60 \ sec \ (qualification); \\ V_{TEST} = 1.2 \ ^*V_{ISO} = 3000 \ V_{RMS}, 1 \ sec \ (100\% \\ production) \end{array}$			2500	V_{RMS}

⁽¹⁾ Measured from input data pin to ground.

NOTE

Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board do not reduce this distance.

Creepage and clearance on a printed circuit board become equal in certain cases. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

Table 1. IEC 60664-1 Ratings Table

PARAMETER	TEST CONDITIONS	SPECIFICATION
Material Group		II
Installation classification / Overvoltage Category for Basic Insulation	Rated mains voltage ≤ 150 V _{RMS}	I–IV
	Rated mains voltage ≤ 300 V _{RMS}	I–III

Product Folder Links: ISO7142CC

⁽²⁾ All pins on each side of the barrier tied together creating a two-terminal device.



8.3.2 Regulatory Information

VDE	UL	CSA	CQC
Certified according to DIN V VDE V 0884-10 (VDE V 0884- 10):2006-12 and DIN EN 61010-1 (VDE 0411-1):2011-07	Certified under UL 1577 Component Recognition Program	Approved under CSA Component Acceptance Notice 5A, IEC 60950-1 and IEC 61010-1	Certified according to GB 4943.1-2011
Basic Insulation; Maximum transient Isolation Isolatilsolationvoltage, 4242 V _{PK} Maximum working isolation voltage, 566 V _{PK}	Single protection, 2500 V _{RMS} ⁽¹⁾	3000 V _{RMS} Isolation rating; 185 V _{RMS} Reinforced Insulation and 370 V _{RMS} Basic Insulation per CSA 60950-1-07+A1+A2 and IEC 60950-1 2nd Ed.+A1+A2; 150 V _{RMS} Reinforced Insulation and 300 V _{RMS} Basic Insulation per CSA 61010-1-12 and IEC 61010-1 3rd Ed.	Basic Insulation, Altitude ≤ 5000m, Tropical climate, 250 V _{RMS} maximum working voltage.
File number: 40016131	File number: E181974	Master contract number: 220991	Certificate number: CQC14001109540

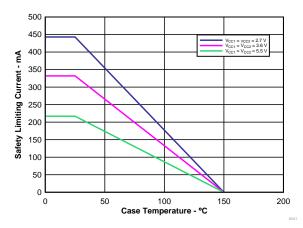
⁽¹⁾ Production tested \geq 3000 V_{RMS} for 1 second in accordance with UL 1577.

8.3.3 Safety Limiting Values

Safety limiting intends to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the IO can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier, potentially leading to secondary system failures.

	PARAMETER		MIN	TYP	MAX	UNIT	
			$\theta_{JA} = 104.5$ °C/W, $V_I = 5.5$ V, $T_J = 150$ °C, $T_A = 25$ °C			217	
IS	Safety input, output, or supply current	DBQ-16	$\theta_{JA} = 104.5$ °C/W, $V_I = 3.6$ V, $T_J = 150$ °C, $T_A = 25$ °C			332	mA
	Carrent		$\theta_{JA} = 104.5$ °C/W, $V_I = 2.7$ V, $T_J = 150$ °C, $T_A = 25$ °C			443	
T_S	Maximum safety temperature					150	°C

The safety-limiting constraint is the absolute-maximum junction temperature specified in the *Absolute Maximum Ratings* table. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the *Thermal Information* table is that of a device installed on a high-K test board for leaded surface-mount packages. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.



NOTE: Thermal Derating Curve for Safety Limiting Current per VDE



8.4 Device Functional Modes

Table 2. Function Table⁽¹⁾

V _{CCI}	V _{cco}	INPUT (INx)	OUTPUT ENABLE (ENx)	OUTPUT (OUTx)
		Н	H or open	Н
DII	PU	L	H or open	L
PU		X	L	Z
		Open	H or open	Н
PD	PU	X	H or open	Н
PD	PU	Х	L	Z
Х	PD	X	X	Undetermined

(1) V_{CCI} = Input-side Supply Voltage; V_{CCO} = Output-side Supply Voltage; PU = Powered Up (V_{CC} ≥ 2.7 V); PD = Powered Down (V_{CC} ≤ 2.1 V); X = Irrelevant; H = High Level; L = Low Level; Z = High Impedance

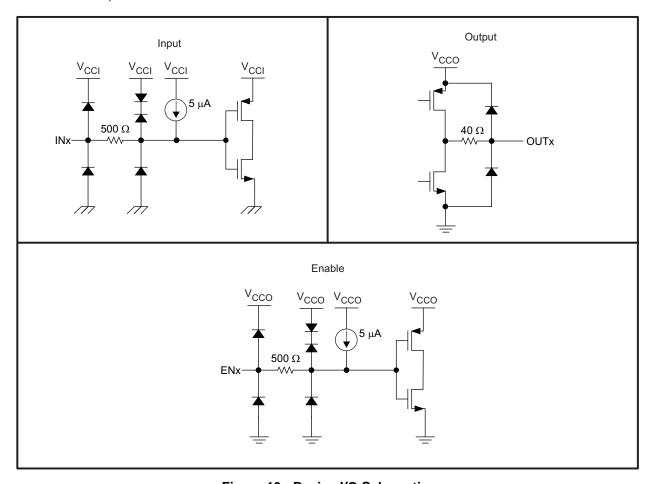


Figure 13. Device I/O Schematics

Product Folder Links: ISO7142CC



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

ISO7142CC uses single-ended TTL-logic switching technology. Its supply voltage range is from 2.7 V to 5.5 V for both supplies, V_{CC1} and V_{CC2} . When designing with digital isolators, it is important to note that due to the single-ended design structure, digital isolators do not conform to any specific interface standard and are only intended for isolating single-ended CMOS or TTL digital signal lines. The isolator is typically placed between the data controller (that is, μ C or UART), and a data converter or a line transceiver, regardless of the interface type or standard.

9.2 Typical Application

Typical isolated RS-232 interface implementation is shown in Figure 14.

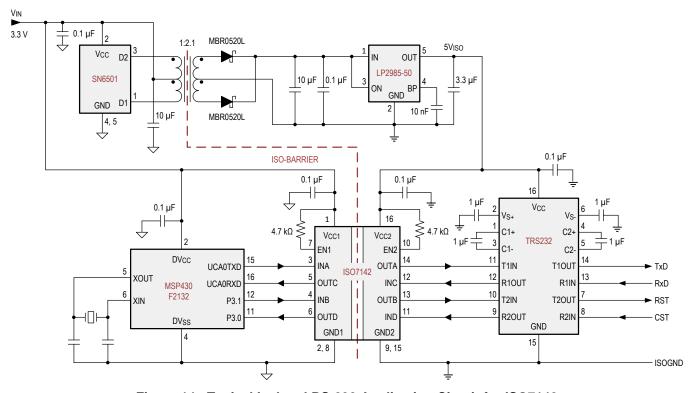


Figure 14. Typical Isolated RS-232 Application Circuit for ISO7142

9.2.1 Design Requirements

Unlike optocouplers, which require external components to improve performance, provide bias, or limit current, ISO7142CC only requires two external bypass capacitors to operate.



Typical Application (continued)

9.2.2 Detailed Design Procedure

Figure 15 shows the hookup of a typical ISO7142CC circuit. The only external components are two bypass capacitors.

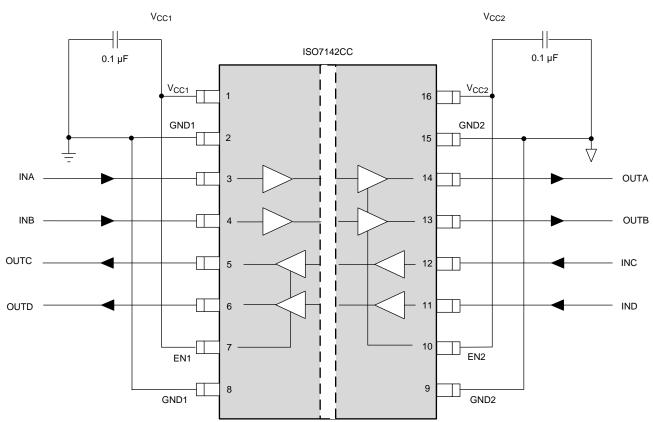


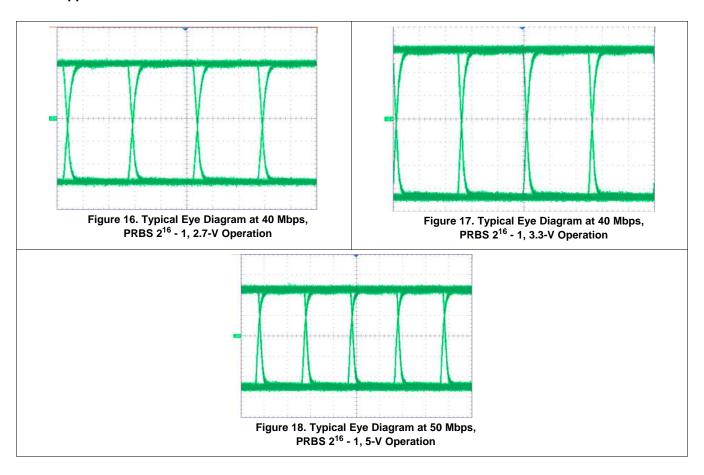
Figure 15. Typical ISO7142CC Circuit Hook-up

Copyright © 2013–2015, Texas Instruments Incorporated



Typical Application (continued)

9.2.3 Application Curves



10 Power Supply Recommendations

To help ensure reliable operation supply voltages, a $0.1-\mu F$ bypass capacitor is recommended at input and output supply pins (V_{CC1} and V_{CC2}). The capacitors should be placed as close to the supply pins as possible. If only a single primary-side power supply is available in an application, isolated power can be generated for the secondary-side with the help of a transformer driver such as Texas Instruments' SN6501. For such applications, detailed power supply design and transformer selection recommendations are available in SN6501 datasheet (SLLSEA0).



11 Layout

11.1 Layout Guidelines

A minimum of four layers is required to accomplish a low EMI PCB design (see Figure 19). Layer stacking should be in the following order (top-to-bottom): high-speed signal layer, ground plane, power plane and low-frequency signal layer.

- Routing the high-speed traces on the top layer avoids the use of vias (and the introduction of their inductances) and allows for clean interconnects between the isolator and the transmitter and receiver circuits of the data link.
- Placing a solid ground plane next to the high-speed signal layer establishes controlled impedance for transmission line interconnects and provides an excellent low-inductance path for the return current flow.
- Placing the power plane next to the ground plane creates additional high-frequency bypass capacitance of approximately 100 pF/in².
- Routing the slower speed control signals on the bottom layer allows for greater flexibility as these signal links
 usually have margin to tolerate discontinuities such as vias.

If an additional supply voltage plane or signal layer is needed, add a second power and ground plane system to the stack to keep it symmetrical. This makes the stack mechanically stable and prevents it from warping. Also the power and ground plane of each power system can be placed closer together, thus increasing the high-frequency bypass capacitance significantly.

For detailed layout recommendations, see Application Note, Digital Isolator Design Guide, SLLA284.

11.1.1 PCB Material

For digital circuit boards operating below 150 Mbps, (or rise and fall times higher than 1 ns), and trace lengths of up to 10 inches, use standard FR-4 UL 94 V-0 printed circuit board. This is preferred over cheaper alternatives because of lower dielectric losses at high frequencies, less moisture absorption, greater strength and stiffness, and self-extinguishing flammability-characteristics.

11.2 Layout Example

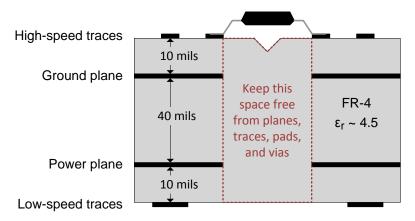


Figure 19. Recommended Layer Stack

Copyright © 2013–2015, Texas Instruments Incorporated



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation, see the following:

- Transformer Driver for Isolated Power Supplies, SLLSEA0
- Digital Isolator Design Guide, SLLA284
- Isolation Glossary, SLLA353

12.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGE OPTION ADDENDUM

26-Mar-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
ISO7142CCDBQ	ACTIVE	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	7142C	Samples
ISO7142CCDBQR	ACTIVE	SSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	7142C	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.



PACKAGE OPTION ADDENDUM

26-Mar-2015

In no event shall TI's liabilit	ty arising out of such information	exceed the total purchase price	ce of the TI part(s) at issue in th	is document sold by TI to Cu	stomer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 26-Mar-2015

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7142CCDBQR	SSOP	DBQ	16	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 26-Mar-2015



*All dimensions are nominal

Device	Package Type Package Drawing		Pins SPQ		Length (mm)	Width (mm)	Height (mm)	
ISO7142CCDBQR	SSOP	DBQ	16	2500	367.0	367.0	35.0	

DBQ (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AB.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive **Amplifiers** amplifier.ti.com Communications and Telecom www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps DSP dsp.ti.com **Energy and Lighting** www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical Logic Security www.ti.com/security logic.ti.com

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

RFID www.ti-rfid.com

OMAP Applications Processors www.ti.com/omap TI E2E Community e2e.ti.com

Wireless Connectivity www.ti.com/wirelessconnectivity